



High Speed CMOS Bus Interface 8-, 9-, and 10-Bit Registers

QS54/74FCT821T
QS54/74FCT823T
QS54/74FCT825T

QS54/74FCT2821T
QS54/74FCT2823T
QS54/74FCT2825T

FEATURES/BENEFITS

- Pin and function compatible to the 74F821/3/5 74FCT821/3/5 and 74FCT821T/3T/5T
- CMOS power levels: <7.5 mW static
- Available in DIP, SOIC, QSOP, ZIP, HQSOP
- Undershoot clamp diodes on all inputs
- TTL-compatible input and output levels
- Ground bounce controlled outputs
- Reduced output swing of 0-3.5V
- Military product compliant to MIL-STD-883

FCT 821T, 823T, 825T

- JEDEC-FCT spec compatible
- Fastest CMOS logic family available
- $I_{OL} = 48 \text{ mA Com.}, 32 \text{ mA Mil.}$

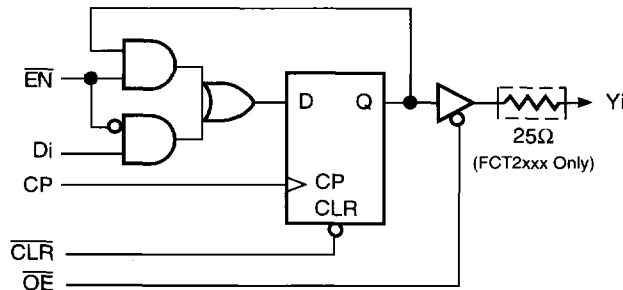
FCT 2821T, 2823T, 2825T

- Built-in 25Ω series resistor outputs reduce reflection and other system noise
- $I_{OL} = 12 \text{ mA Com.}$

DESCRIPTION

The QSFC821T/823T/825T and QSFC2821T/2823T/2825T are 10-, 9-, and 8-bit high-speed CMOS TTL-compatible buffered registers with three-state outputs that are ideal for driving high capacitance loads such as memory and address buses. The 2821/3/5 devices are 25Ω resistor output versions useful for driving transmission lines and reducing system noise. The 2821 series parts can replace the 821 series to reduce noise in an existing design. All inputs have clamp diodes for undershoot noise suppression. All outputs have ground bounce suppression (see QSI Application Note AN-001), and outputs will not load an active bus when Vcc is removed from the device.

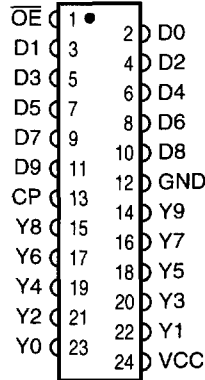
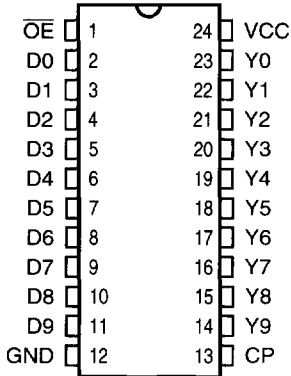
FUNCTIONAL BLOCK DIAGRAM



FCT821 - 10 BIT REGISTER
PIN CONFIGURATIONS (All Pins Top View)

PDIP, SOIC, QSOP, HQSOP

ZIP

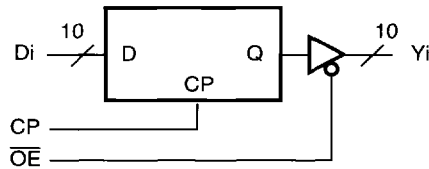


3

PIN DESCRIPTION

Name	I/O	Description
Di	I	Data Inputs
Yi	O	Data Outputs-Three State
CP	I	Clock Pulse
\overline{OE}	I	Output Enable

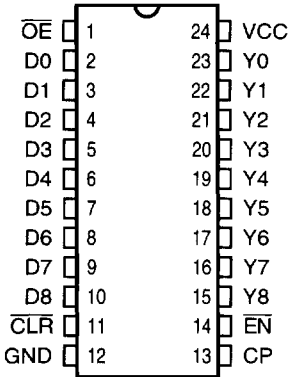
FCT821 LOGIC SYMBOL



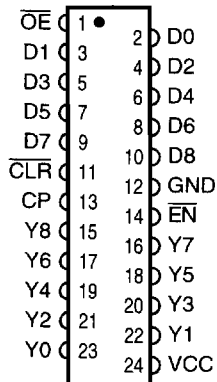
FCT823 - 9 BIT REGISTER

PIN CONFIGURATIONS (All Pins Top View)

PDIP, SOIC, QSOP, HQSOP



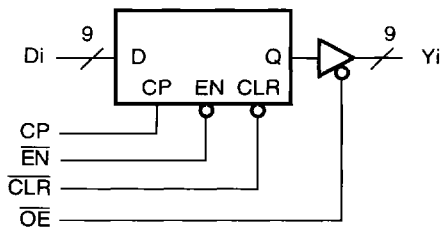
ZIP



PIN DESCRIPTION

Name	I/O	Description
Di	I	Data Inputs
Yi	O	Data Outputs-Three State
\overline{OE}	I	Output Enable
CP	I	Clock Pulse
\overline{EN}	I	Clock Enable
\overline{CLR}	I	Asynchronous Reset

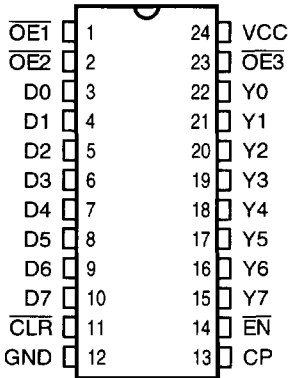
FCT823 LOGIC SYMBOL



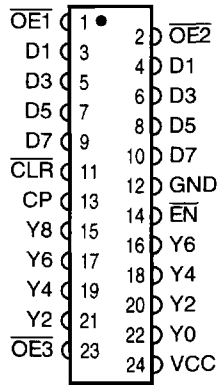
FCT825 - 8 BIT REGISTER

PIN CONFIGURATIONS (All Pins Top View)

PDIP, SOIC, QSOP, HQSOP



ZIP

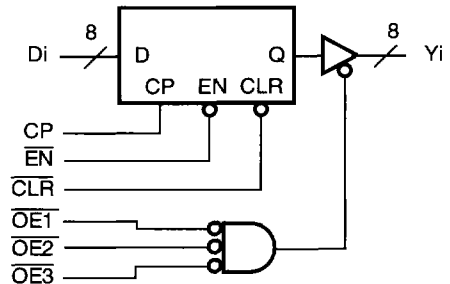


3

PIN DESCRIPTION

Name	I/O	Description
Di	I	Data Inputs
Yi	O	Data Outputs-Three State
\overline{OE}	I	Output Enable
CP	I	Clock Pulse
\overline{EN}	I	Clock Enable
\overline{CLR}	I	Asynchronous Reset

FCT825 LOGIC SYMBOL



FUNCTION TABLE

Inputs					Int.	O/P	Function
\overline{OE}	\overline{CLR}	\overline{EN}	Di	CP	Qi	Yi	
H	X	L	L	↑	L	Hi-Z	High Z
H	X	L	H	↑	H	Hi-Z	High Z
H	L	X	X	X	L	Hi-Z	Clear
L	L	X	X	X	L	L	Clear
H	H	H	X	X	NC	Hi-Z	Hold
L	H	H	X	X	NC	NC	Hold
H	H	L	L	↑	L	Hi-Z	Load
H	H	L	H	↑	H	Hi-Z	Load
L	H	L	L	↑	L	L	Load
L	H	L	H	↑	H	H	Load

Note: For the 821, the HI-Z and Load functions only apply as the \overline{EN} and \overline{CLR} are not present in these devices. For the 825, there are three output enables, and the composite output enable is asserted on when all three are LOW. If any one of the three output enables are HIGH, the output is disabled.

ABSOLUTE MAXIMUM RATINGS

Supply Voltage to Ground	-0.5V to +7.0V
DC Output Voltage V_{OUT}	-0.5V to +7.0V
DC Input Voltage V_{IN}	-0.5V to +7.0V
AC Input Voltage (for a pulse width \leq 20 ns)	-3.0V
DC Input Diode Current with $V_{IN} < 0$	-20 mA
DC Output Diode Current with $V_{OUT} < 0$	-50 mA
DC Output Current Max. Sink Current/Pin	120 mA
Maximum Power Dissipation	0.5 watts
T_{STG} Storage Temperature	-65° to +150°C

Note: Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to QSI devices that result in functional or reliability type failures.

CAPACITANCE

$T_A = 25^\circ\text{C}$, $f = 1\text{ MHz}$, $V_{IN} = 0\text{V}$, $V_{OUT} = 0\text{V}$

Pins	SOIC	QSOP	PDIP	ZIP	Unit
1, 3-11, 13	4	4	5	7	pF
15-22	6	6	7	9	pF
2, 14, 23	8	8	9	10	pF

Note: Capacitance is characterized but not tested.

POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾	Min	Max	Unit
I_{CC}	Quiescent Power Supply Current	$V_{CC} = \text{Max.}$, $\text{freq} = 0$ $0\text{V} \leq V_{IN} \leq 0.2\text{V}$ or $V_{CC}-0.2\text{V} \leq V_{IN} \leq V_{CC}$	—	1.5	mA
ΔI_{CC}	Supply Current per Input @ TTL HIGH	$V_{CC} = \text{Max.}$, $V_{IN} = 3.4\text{V}$, $\text{freq} = 0$ ⁽²⁾	—	2.0	mA
Q_{CCD}	Supply Current per Input per MHz	$V_{CC} = \text{Max.}$, Outputs open and enabled One bit toggling @ 50% duty cycle Other inputs at GND or V_{CC} ^(3,4)	—	0.25	mA/MHz

Notes:

- For conditions shown as Min. or Max., use the appropriate values specified under DC specifications.
- Per TTL driven input ($V_{IN} = 3.4\text{V}$).
- For flip-flops, Q_{CCD} is measured by switching one of the data input pins so that the output changes every clock cycle. This is a measurement of device power consumption only and does not include power to drive load capacitance or tester capacitance. This parameter is guaranteed by design but not tested.
- I_C can be computed using the above parameters as explained in the Technical Overview section.

QSFACT821T, 823T, 825T, 2821T, 2823T, 2825T

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Commercial $T_A = 0^\circ\text{C}$ to 70°C , $V_{CC} = 5.0\text{V} \pm 5\%$

Military $T_A = -55^\circ\text{C}$ to 125°C , $V_{CC} = 5.0\text{V} \pm 10\%$

Symbol	Parameter	Test Conditions	Min	Typ ⁽¹⁾	Max	Unit
V_{IH}	Input HIGH Voltage	Logic HIGH for All Inputs	2.0	—	—	V
V_{IL}	Input LOW Voltage	Logic LOW for All Inputs	—	—	0.8	V
ΔV_T	Input Hysteresis	$V_{TLH} - V_{THL}$ for All Inputs	—	0.2	—	V
$ I_{IH} $ $ I_{IL} $	Input Current Input HIGH or LOW	$V_{CC} = \text{Max.}, 0 \leq V_{IN} < V_{CC}$	—	—	5	μA
$ I_{OZ} $	Off-State Output Current (Hi-Z)	$V_{CC} = \text{Max.}, 0 \leq V_{IN} \leq V_{CC}$	—	—	5	μA
I_{OS}	Short Circuit Current (FCTXXX)	$V_{CC} = \text{Max.}, V_{OUT} = \text{GND}^{(2,3)}$	-60	—	—	mA
I_{OR}	Current Drive (FCT2XXX)	$V_{CC} = \text{Min.}, V_{OUT} = 2.0\text{V}^{(3)}$	50	—	—	mA
V_{IC}	Input Clamp Voltage	$V_{CC} = \text{Min.}, I_{IN} = -18 \text{ mA}, T_A = 25^\circ\text{C}^{(3)}$	—	-0.7	-1.2	V
V_{OH}	Output HIGH Voltage	$V_{CC} = \text{Min.}$ $I_{OH} = -15 \text{ mA (MIL)}$ $I_{OH} = -24 \text{ mA (COM)}$	2.4 2.4	— —	— —	V
V_{OL}	Output LOW Voltage (FCTXXX)	$V_{CC} = \text{Min.}$ $I_{OL} = 32 \text{ mA (MIL)}$ $I_{OL} = 48 \text{ mA (COM)}$	— —	— —	0.50 0.50	V
V_{OL}	Output LOW Voltage (FCT2XXX- 25 Ω)	$V_{CC} = \text{Min.}$ $I_{OL} = 12 \text{ mA (MIL)}$ $I_{OL} = 12 \text{ mA (COM)}$	— —	— —	0.50 0.50	V
R_{OUT}	Output Resistance (FCT2XXX- 25 Ω)	$V_{CC} = \text{Min.}$ $I_{OL} = 12 \text{ mA (MIL)}$ $I_{OL} = 12 \text{ mA (COM)}$	— 20	25 28	— 40	Ω

Notes:

1. Typical values indicate $V_{CC} = 5.0\text{V}$ and $T_A = 25^\circ\text{C}$.
2. Not more than one output should be shorted and the duration is ≤ 1 second.
3. These parameters are guaranteed by design but not tested.

3

QSFCT821T, 823T, 825T, 2821T, 2823T, 2825T

SWITCHING CHARACTERISTICS OVER OPERATING RANGE

Commercial T_A = 0°C to 70°C, V_{CC} = 5.0V ± 5%

Military T_A = -55°C to 125°C, V_{CC} = 5.0V ± 10%

C_{LOAD} = 50 pF, R_{LOAD} = 500Ω unless otherwise noted.

Symbol	Description ⁽¹⁾		821A 823A 825A 2821A 2823A 2825A		821B 823B 825B 2821B 2823B 2825B		821C 823C 825C 2821C 2823C		821D 823D 2821D 2823D		Unit
			Min	Max	Min	Max	Min	Max	Min	Max	
t _{PHL} t _{PLH}	Clock to Y Delay $\overline{OE} = \text{LOW}$, 821/3/5	Com Mil		10 11.5		7.5 8.5		6.0 7.0		5.3	ns
t _{PHL} t _{PLH}	Clock to Y Delay ^(2,3) $\overline{OE} = \text{LOW}$, 821/3/5	Com Mil		20 20		15 16		12.5 13.5		12.5	ns
t _{PHL} t _{PLH}	Clock to Y Delay $\overline{OE} = \text{LOW}$, 2821/3/5	Com Mil		10 11.5		7.5 8.5		6.0		5.3	ns
t _{PHL} t _{PLH}	Clock to Y Delay ^(2,3) $\overline{OE} = \text{LOW}$, 2821/3/5	Com Mil		20 20		15 16		12.5		12.5	ns
ts	Data to CP Setup Time	Com Mil	4.0 4.0		3.0 3.0		3.0 3.0		3.0		ns
th	Data to CP Hold Time	Com Mil	2.0 2.0		1.5 1.5		1.5 1.5		1.5		ns
t _{ENS}	\overline{EN} to CP Setup Time	Com Mil	4.0 4.0		3.0 3.0		3.0 3.0		3.0		ns
t _{ENH}	\overline{EN} to CP Hold Time	Com Mil	2.0 2.0		0.0 0.0		0.0 0.0		0.0		ns

Notes:

1. See Test Circuit and Waveforms.
2. This parameter is guaranteed by design but not tested.
3. C_{LOAD} = 300 pF

QSFCT821T, 823T, 825T, 2821T, 2823T, 2825T

TIMING REQUIREMENTS OVER OPERATING RANGE

Commercial T_A = 0°C to 70°C, V_{CC} = 5.0V ± 5%

Military T_A = -55°C to 125°C, V_{CC} = 5.0V ± 10%

C_{LOAD} = 50 pF, R_{LOAD} = 500Ω unless otherwise noted.

Symbol	Description ⁽¹⁾		821A 823A 825A 2821A 2823A 2825A		821B 823B 825B 2821B 2823B 2825B		821C 823C 825C 2821C 2823C		821D 823D 2821D 2823D		Unit
			Min	Max	Min	Max	Min	Max	Min	Max	
t _{CLR}	$\overline{\text{CLR}}$ to Y Delay 823/5	Com Mil		11 12		9.0 9.5		8.0 8.5		7.0	ns
t _{CLR}	$\overline{\text{CLR}}$ to Y Delay 2823/5	Com Mil		11 12		9.0 9.5		8.0		7.0	ns
t _{REC}	$\overline{\text{CLR}}$ to CP Setup Time	Com Mil	6.0 7.0		6.0 6.0		6.0 6.0		6.0		ns
t _{PWH} t _{PWL}	Clock Pulse Width ⁽²⁾ HIGH or LOW	Com Mil	7.0 7.0		6.0 6.0		6.0 6.0		6.0		ns
t _{PZH} t _{PZL}	Output Enable Time $\overline{\text{OE}}$ to Y _i , 821/3/5	Com Mil		12 13		8.0 9.0		7.0 8.0		6.5	ns
t _{PZH} t _{PZL}	Output Enable Time ^(2,3) $\overline{\text{OE}}$ to Y _i , 821/3/5	Com Mil		23 25		15 16		12.5 13.5		12.5	ns
t _{PZH} t _{PZL}	Output Enable Time $\overline{\text{OE}}$ to Y _i , 2821/3/5	Com Mil		12 13		8.0 9.0		7.0		6.5	ns
t _{PZH} t _{PZL}	Output Enable Time ^(2,3) $\overline{\text{OE}}$ to Y _i , 2821/3/5	Com Mil		23 25							ns
t _{PHZ} t _{PLZ}	Output Disable Time ^(2,4) $\overline{\text{OE}}$ to Y _i	Com Mil		7.0 8.0		6.5 7.0		6.2 6.2		6.2	ns
t _{PHZ} t _{PLZ}	Output Disable Time ⁽²⁾ $\overline{\text{OE}}$ to Y _i	Com Mil		9.0 10		7.5 8.0		6.5 6.5		6.5	ns

Notes:

1. See Test Circuit and Waveforms.
2. This parameter is guaranteed by design but not tested.
3. C_{LOAD} = 300 pF
4. C_{LOAD} = 5 pF

3